Nuclear Event Detector Engineering Model





For evaluation, early prototyping and radiation testing, Micross offers its Engineering Model version of the NED: Its characteristics are indicated in Table 1.

Table 1. Engineering Model NED	
Parameter	Value
Part Number	MYXRHNEDHCJ/EM
Minimum Dose Rate Threshold	5 x 10 ⁴ rads(Si)/sec
Radiation-to-Output Delay Time	15 ns @2x Overdrive at Minimum Dose Rate Threshold
Outputs	Pulse and Latched Level; Differential
Packaging	44-Pin J-Lead, Ceramic, Non-Hermetic
Screening	Screened in accordance with internal Micross procedures. Material sourced by Micross Engineering.
Temperature Range	Designed to Operate from -55°C to +125°C, but Tested at Only 25 °C.
100% Radiation Tested for Minimum Dose Rate Threshold	No
Prompt Dose Survival Level	5 x 10 ¹⁰ rads(Si)/sec (Tested)
Prompt Dose Rate Operate Through Capable	Current Units Limited to 2.5 x 10 ⁹ rads(Si)/sec
Neutron Fluence (Device Survivability)	5 x 10 ¹³ n/cm ² (Not Tested)

